In situ small angle X-ray scattering to reveal the formation of materials for nanoenergetics.

Heinz Amenitsch Austrian Academy of Sciences, Austria

Simultaneous Small and Wide Angle X-ray Scattering (SWAXS) on both, bulk as well on surfaces, is used as standard tool for the structural characterization of materials used in nanoenergetics. Based on some exemplary investigations, this presentation should highlight the use and the information content obtained by using this method. The focus will lay on *in situ* experiments using synchrotron radiation, which reveals simultaneously the supramolecular and atomic structure of the investigated nanomaterials.

The presented topics will cover:

(i) *in situ* characterization of mesporous thin films, which find application as low dielectric material in the electronic industry or as photovoltaic materials used in a Grätzl cell [1]

(ii) in situ grazing incidence study of the formation of Copper zinc tin sulfide $(Cu_2ZnSnS_4, CZTS)$, which is very promising solar absorber material with a high optical absorption coefficient and an ideal band gap for photovoltaic applications. [2]

(iii) *in situ*, real-time combined SWAXS investigaton during the colloidal synthesis of zinc sulfide nanoparticles, which have potential applications in photonic crystals, photovoltaics and optoelectronic devices [3]

References

[1] Malfatti,L. *et al.* Mesostructured self-assembled titania films for photovoltaic applications. *Microporous Mesoporous Mater.* **88**, 304-311 (2006).

[2] Fischereder, A. *et al.* Investigation of Cu2ZnSnS4 formation from metal salts and thioacetamide. *Chem. Mater.* **22**, 3399-3406 (2010).

[3] J. Novák, T. Rath, A. Pein, A. Fischereder, W. Haas, H. Amenitsch, F. Hofer, G. Trimmel, *in preparation*